Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/821,754	SCHMID ET AL.	
Examiner	Art Unit	_
Filen C. Tran	2134	

	SEAR	CHED	
Class	Subclass	Date	Examiner
713	164	3/3/2006	ECT
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
Interferen	ce Search	3/3/2006	ECT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	3/3/2006	ECT
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